

<b>Notice of References Cited</b>	Application/Control No. 10/552,814	Applicant(s)/Patent Under Reexamination THELEN ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,498,628	12-2002	Iwamura, Ryuichi	348/734
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